

CY14B256KA

256-Kbit (32 K × 8) nvSRAM with Real Time Clock

Features

- 256-Kbit nonvolatile static random access memory (nvSRAM) □ 25 ns and 45 ns access times
 - □ Internally organized as 32 K × 8 (CY14B256KA)
 - Hands off automatic STORE on power-down with only a small capacitor
 - STORE to QuantumTrap nonvolatile elements is initiated by software, hardware, or AutoStore on power-down
 - RECALL to SRAM initiated on power-up or by software
- High reliability
 - □ Infinite Read, Write, and RECALL cycles
 - I million STORE cycles to QuantumTrap
 - 20 year data retention
- Real time clock (RTC)
 - Full-featured real time clock
 - Watchdog timer
 - Clock alarm with programmable interrupts
 - Capacitor or battery backup for RTC
 - □ Backup current of 0.35 µA (Typ)

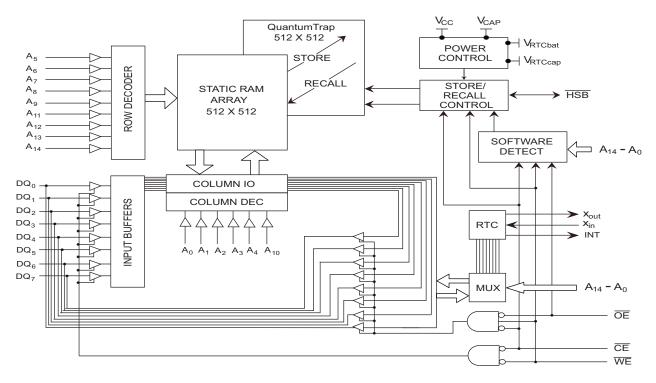
- Industry standard configurations
- □ Single 3 V +20%, -10% operation
- Industrial temperature
- □ 48-pin shrink small-outline package (SSOP)
- Pb-free and Restriction of hazardous substances (RoHS) compliant

Functional Description

The Cypress CY14B256KA combines a 256-Kbit nonvolatile static RAM with a full featured real time clock in a monolithic integrated circuit. The embedded nonvolatile elements incorporate QuantumTrap technology producing the world's most reliable nonvolatile memory. The SRAM is read and written an infinite number of times, while independent nonvolatile data resides in the nonvolatile elements.

The real time clock function provides an accurate clock with leap year tracking and a programmable, high accuracy oscillator. The alarm function is programmable for periodic minutes, hours, days, or months alarms. There is also a programmable watchdog timer for process control.

For a complete list of related documentation, click here.



Logic Block Diagram



CY14B256KA

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Pinouts

Figure 1. 48-pin SSOP pinout $\begin{array}{c|c} V_{CAP} & 1 \\ NC^{[1]} & 2 \\ A_{14} & 3 \\ A_{12} & 4 \\ A_{7} & 4 \end{array}$ □v_{cc} □nc^[1] \bigcirc 48 47 46 HSB 45 WE A7 5 44 A₆ 6 43 _ A₈ 42 A9 A₅ 7 INT 8 INT 8 A₄ 9 NC 10 NC 11 NC 12 Vss 13 NC 14 V_{RTCDat} 15 DQ0 16 A₃ 17 A₂ 18 A₁ 19 A₀ 20 DQ1 21 41 🗆 NC 48 - SSOP 40 A11 (x8) □NC 39 38 **Top View** NC 37 (not to scale) 36 □ V_{SS} □ NC 35 34 VRTCcap 33 🗖 DQ6 32 31 30 CE 29 DQ7 DQ121 28 🗖 DQ5 DQ2 22 Xout 23 Xin 24 27 🗌 DQ4 26 DQ3 25 V_{CC}

Pin Definitions

Pin Name	I/O Type	Description
A ₀ -A ₁₄	Input	Address inputs. Used to select One of the 32,768 bytes of the nvSRAM.
DQ ₀ -DQ ₇	Input/Output	Bidirectional data I/O Lines. Used as input or output lines depending on operation.
NC	No connect	No connect. This pin is not connected to the die.
WE	Input	Write Enable input, Active LOW. When the chip is enabled and $\overline{\text{WE}}$ is LOW, data on the I/O pins is written to the specific address location.
CE	Input	Chip Enable input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.
ŌĒ	Input	Output Enabl <u>e, Active LOW. The active LOW OE</u> input enables the data output buffers during read cycles. Deasserting OE HIGH causes the I/O pins to tristate.
X _{out} ^[2]	Output	Crystal connection. Drives crystal on start up.
X _{in} ^[2]	Input	Crystal connection. For 32.768 kHz crystal.
	Power supply	Capacitor supplied backup RTC supply voltage. Left unconnected if V _{RTCbat} is used.
V _{RTCbat} ^[2]	Power supply	Battery supplied backup RTC supply voltage. Left unconnected if V _{RTCcap} is used.
INT ^[2]	Output	Interrupt output. Programmable to respond to the clock alarm, the watchdog timer, and the power monitor. Also programmable to either active HIGH (push or pull) or LOW (open drain).
V _{SS}	Ground	Ground for the device. Must be connected to the ground of the system.
V _{CC}	Power supply	Power supply inputs to the Device. 3.0 V +20%, -10%
HSB	Input/Output	Hardware STORE Busy (HSB) Output: Ind <u>icate</u> s busy status of nvSRAM when LOW. After each Hardware and Software STORE operation, HSB is driven HIGH for a short time (t _{HHHD}) with standard output high current and then a weak internal pull-up resistor keeps this pin HIGH (external pull-up resistor connection optional). Input: Hardware STORE implemented by pulling this pin LOW externally.
V _{CAP}	Power supply	AutoStore capacitor. Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.

Notes

Address expansion for 1-Mbit. NC pin not connected to die.
 Left unconnected if RTC feature is not used.



Device Operation

The CY14B256KA nvSRAM is made up of two functional components paired in the same physical cell. These are a SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations SRAM read and write operations are inhibited. The CY14B256KA supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations. Refer the Truth Table For SRAM Operations on page 24 for a complete description of read and write modes.

SRAM Read

The CY14B256KA performs a read cycle whenever CE and OE are LOW, and WE and HSB are HIGH. The address specified on pins A_{0-14} determines which of the 32,768 data bytes are accessed. When the read is initiated by an address transition, the outputs are valid after a delay of t_{AA} (read cycle #1). If the read is initiated by CE or OE, the outputs are valid at t_{ACE} or at t_{DOE} , whichever is later (read cycle #2). The data output repeatedly responds to address changes within the t_{AA} access time without the need for transitions on any control input pins. This remains valid until another address change or until CE or OE is brought HIGH, or WE or HSB is brought LOW.

SRAM Write

A write cycle is performed when \overline{CE} and \overline{WE} are LOW and \overline{HSB} is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until \overline{CE} or \overline{WE} goes HIGH at the end of the cycle. The data on the common I/O pins IO_{0-7} are written into the memory if it is valid t_{SD} before the end of a WE-controlled write, or before the end of an \overline{CE} -controlled write. It is recommended that \overline{OE} be kept HIGH during the entire write cycle to avoid data bus contention on common I/O lines. If \overline{OE} is left LOW, internal circuitry turns off the output buffers t_{HZWE} after WE goes LOW.

AutoStore Operation

The CY14B256KA stores data to the nvSRAM using one of three storage operations. These three operations are: Hardware STORE, activated by the HSB; Software STORE, activated by an address sequence; AutoStore, on device power-down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B256KA.

During normal operation, the device draws current from V_{CC} to charge a capacitor connected to the V_{CAP} pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the V_{CC} pin drops below V_{SWITCH} , the part automatically disconnects the V_{CAP} pin from V_{CC} . A STORE operation is initiated with power provided by the V_{CAP} capacitor.

Note If the capacitor is not connected to V_{CAP} pin, AutoStore must be disabled using the soft sequence specified in Preventing AutoStore on page 6. In case AutoStore is enabled without a capacitor on V_{CAP} pin, the device attempts an AutoStore operation without sufficient charge to complete the Store. This corrupts the data stored in nvSRAM.

Figure 2. AutoStore Mode

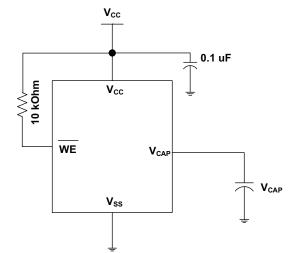


Figure 2 shows the proper connection of the storage capacitor (V_{CAP}) for automatic STORE operation. Refer to DC Electrical Characteristics on page 16 for the size of the V_{CAP} . The voltage on the V_{CAP} pin is driven to V_{CC} by a regulator on the chip. Place a pull-up on WE to hold it inactive during power-up. This pull-up is only effective if the WE signal is tristate during power-up. Many MPUs tristate their controls on power-up. This must be verified when using the pull-up. When the nvSRAM comes out of power-on-RECALL, the MPU must be active or the WE held inactive until the MPU comes out of reset.

To reduce unnecessary nonvolatile stores, AutoStore and Hardware STORE operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place.

Hardware STORE (HSB) Operation

The CY14B256KA provides the HSB pin to control and acknowledge the STORE operations. The HSB pin is used to request a Hardware STORE cycle. When the HSB pin is driven LOW, the CY14B256KA conditionally initiates a STORE operation after t_{DELAY} . An actual STORE cycle begins only if a write to the SRAM has taken place since the last STORE or RECALL cycle. The HSB pin also acts as an open drain driver (internal 100 k Ω weak pull-up resistor) that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

Note After each Hardware and Software STORE operation HSB is driven HIGH for a short time (t_{HHHD}) with standard output high current and then remains HIGH by internal 100 k Ω pull-up resistor.

SRAM write operations that are in progress when $\overline{\text{HSB}}$ is driven LOW by any means are given time (t_{DELAY}) to complete before the STORE operation is initiated. However, any SRAM write cycles requested after HSB goes LOW are in<u>hibited</u> until HSB returns HIGH. In case the write latch is not set, HSB is not driven LOW by the CY14B256KA. But any SRAM read and write cycles are inhibited until HSB is returned HIGH by MPU or other external source.

During any STORE operation, regardless of how it is initiated, the CY14B256KA continues to drive the HSB pin LOW, releasing



it only when the STORE is complete. Upon completion of the STORE operation, the nvSRAM memory access is inhibited for t_{LZHSB} time after HSB pin returns HIGH. Leave the HSB unconnected if it is not used.

Hardware RECALL (Power-Up)

During power-up or after any low power condition (V_{CC}
 V_{SWITCH}), an internal RECALL request is latched. When V_{CC} again exceeds the V_{SWITCH} on powerup, a RECALL cycle is automatically initiated and takes t_{HRECALL} to complete. During this time, the HSB pin is driven LOW by the HSB driver and all reads and writes to nvSRAM are inhibited.

Software STORE

Data is transferred from the SRAM to the nonvolatile memory by a software address sequence. The CY14B256KA<u>S</u>oftware STORE cycle is initiated by executing sequential CE or OE controlled read cycles from six specific address locations in exact order. During the STORE cycle, an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of reads from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place.

To initiate the Software STORE cycle, the following read sequence must be performed:

- 1. Read address 0x0E38 Valid READ
- 2. Read address 0x31C7 Valid READ
- 3. Read address 0x03E0 Valid READ

- 4. Read address 0x3C1F Valid READ
- 5. Read address 0x303F Valid READ
- 6. Read address 0x0FC0 Initiate STORE cycle

Th<u>e software sequence may be clocked with CE controlled reads</u> or OE controlled reads, with WE kept HIGH for all the six READ sequences. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled. HSB is driven LOW. After the t_{STORE} cycle time is fulfilled, the SRAM is activated again for the read and write operation.

Software RECALL

Data is transferred from the nonvolatile memory to the SRAM by a software address sequence. A Software RECALL cycle is initiated with a sequence of read operations in a manner similar to the Software STORE initiation. To initiate the RECALL cycle, the following sequence of CE or OE controlled read operations must be performed:

- 1. Read address 0x0E38 Valid READ
- 2. Read address 0x31C7 Valid READ
- 3. Read address 0x03E0 Valid READ
- 4. Read address 0x3C1F Valid READ
- 5. Read address 0x303F Valid READ
- 6. Read address 0x0C63 Initiate RECALL cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared. Next, the nonvolatile information is transferred into the SRAM cells. After the t_{RECALL} cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.





Table 1. Mode Selection

CE	WE	OE	A ₁₄ –A ₀ ^[3]	Mode	I/O	Power
Н	Х	Х	X	Not Selected	Output High Z	Standby
L	Н	L	Х	Read SRAM	Output Data	Active
L	L	Х	Х	Write SRAM	Input Data	Active
L	Н	L	0x0E38 0x31C7 0x03E0 0x3C1F 0x303F 0x0B45	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Disable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[4]
L	Н	L	0x0E38 0x31C7 0x03E0 0x3C1F 0x303F 0x0B46	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Enable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[4]
L	н	L	0x0E38 0x31C7 0x03E0 0x3C1F 0x303F 0x0FC0	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile STORE	Output Data Output Data Output Data Output Data Output Data Output High Z	Active I _{CC2} ^[4]
L	Н	L	0x0E38 0x31C7 0x03E0 0x3C1F 0x303F 0x0C63	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile RECALL	Output Data Output Data Output Data Output Data Output Data Output High Z	Active ^[4]

Preventing AutoStore

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the Software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE or OE controlled read operations must be performed:

- 1. Read address 0x0E38 Valid READ
- 2. Read address 0x31C7 Valid READ
- 3. Read address 0x03E0 Valid READ
- 4. Read address 0x3C1F Valid READ
- 5. Read address 0x303F Valid READ
- 6. Read address 0x0B45 AutoStore Disable

The AutoStore is reenabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the Software RECALL initiation.

To initiate the AutoStore enable sequence, the following sequence of CE or OE controlled read operations must be performed:

- 1. Read address 0x0E38 Valid READ
- 2. Read address 0x31C7 Valid READ
- 3. Read address 0x03E0 Valid READ
- 4. Read address 0x3C1F Valid READ
- 5. Read address 0x303F Valid READ
- 6. Read address 0x0B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (Hardware or Software) issued to save the AutoStore state through subsequent power-down cycles. The part comes from the factory with AutoStore enabled and 0x00 written in all cells.

Data Protection

The CY14B256KA protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when V_{CC} is less than V_{SWITCH} . If the CY14B256KA is in a write mode (both CE and WE are LOW) at power-up, after a RECALL or STORE, the write is inhibited until the SRAM is enabled after t_{LZHSB} (HSB to output active). This protects against inadvertent writes during power-up or brown out conditions.

Notes

^{3.} While there are 15 address lines on the CY14B256KA, only the lower 14 are used to control software modes.

^{4.} The six consecutive address locations must be in the order listed. WE must be HIGH during all six cycles to enable a nonvolatile cycle.



Real Time Clock Operation

nvTIME Operation

The CY14B256KA offers internal registers that contain clock, alarm, watchdog, interrupt, and control functions. RTC registers use the last 16 address locations of the SRAM. Internal double buffering of the clock and timer information registers prevents accessing transitional internal clock data during a read or write operation. Double buffering also circumvents disrupting normal timing counts or the clock accuracy of the internal clock when accessing clock data. Clock and alarm registers store data in BCD format.

RTC functionality is described in the following sections. The RTC register addresses for CY14B256KA range from 0x7FF0 to 0x7FFF. Refer to Table 3 on page 12 and Table 4 on page 13 for a detailed Register Map description.

Clock Operations

The clock registers maintain time up to 9,999 years in one-second increments. The time can be set to any calendar time and the clock automatically keeps track of days of the week and month, leap years, and century transitions. There are eight registers dedicated to the clock functions, which are used to set time with a write cycle and to read time with a read cycle. These registers contain the time of day in BCD format. Bits defined as '0' are currently not used and are reserved for future use by Cypress.

Reading the Clock

The double buffered RTC register structure reduces the chance of reading incorrect data from the clock. Internal updates to the CY14B256KA time keeping registers are stopped when the read bit 'R' (in the flags register at 0x7FF0) is set to '1' before reading clock data to prevent reading of data in transition. Stopping the register updates does not affect clock accuracy.

When a read sequence of RTC device is initiated, the update of the user timekeeping registers stops and does not restart until a '0' is written to the read bit 'R' (in the flags register at 0x7FF0). After the end of read sequence, all the RTC registers are simultaneously updated within 20 ms.

Setting the Clock

A write access to the RTC device stops updates to the time keeping registers and enables the time to be set when the write bit 'W' (in the flags register at 0x7FF0) is set to '1'. The correct day, date, and time is then written into the registers and must be in 24 hour BCD format. The time written is referred to as the "Base Time". This value is stored in nonvolatile registers and used in the calculation of the current time. When the write bit 'W' is cleared by writing '0' to it, the values of timekeeping registers are transferred to the actual clock counters after which the clock resumes normal operation.

If the time written to the timekeeping registers is not in the correct BCD format, each invalid nibble of the RTC registers continue counting to 0xF before rolling over to 0x0 after which RTC resumes normal operation.

Note After 'W' bit is set to '0', values written into the timekeeping, alarm, calibration, and interrupt registers are transferred to the RTC time keeping counters in t_{RTCp} time. These counter values must be saved to nonvolatile memory either by initiating a

Backup Power

The RTC in the CY14B256KA is intended for permanently powered operation. The V_{RTCcap} or V_{RTCbat} pin is connected depending on whether a capacitor or battery is chosen for the application. When the primary power, V_{CC}, fails and drops below V_{SWITCH} the device switches to the backup power supply.

The clock oscillator uses very little current, which maximizes the backup time available from the backup source. Regardless of the clock operation with the primary source removed, the data stored in the nvSRAM is secure, having been stored in the nonvolatile elements when power was lost.

During backup operation, the CY14B256KA consumes a $0.35 \ \mu A$ (Typ) at room temperature. The user must choose capacitor or battery values according to the application.

Note: If a battery is applied to V_{RTCbat} pin prior to V_{CC}, the chip will draw high I_{BAK} current. This occurs even if the oscillator is disabled. In order to maximize battery life, V_{CC} must be applied before a battery is applied to V_{RTCbat} pin.

Backup time values based on maximum current specifications are shown in the following Table 2. Nominal backup times are approximately two times longer.

Table 2. RTC Backup Time

Capacitor Value	Backup Time
0.1 F	72 hours
0.47 F	14 days
1.0 F	30 days

Using a capacitor has the obvious advantage of recharging the backup source each time the system is powered up. If a battery is used, a 3 V lithium is recommended and the CY14B256KA sources current only from the battery when the primary power is removed. However, the battery is not recharged at any time by the CY14B256KA. The battery capacity must be chosen for total anticipated cumulative down time required over the life of the system.

Stopping and Starting the Oscillator

The OSCEN bit in the calibration register at 0x7FF8 controls the enable and disable of the oscillator. This bit is nonvolatile and is shipped to customers in the "enabled" (set to '0') state. To preserve the battery life when the system is in storage, OSCEN must be set to '1'. This turns off the oscillator circuit, extending the battery life. If the OSCEN bit goes from disabled to enabled, it takes approximately one second (two seconds maximum) for the oscillator to start.

While system power is off, if the voltage on the backup supply (V_{RTCcap} or V_{RTCbat}) falls below their respective minimum level, the oscillator may fail. The CY14B256KA has the ability to detect oscillator failure when system power is restored. This is recorded in the Oscillator Fail Flag (OSCF) of the flags register at the address 0x7FF0. When the device is powered on (V_{CC} goes above V_{SWITCH}) the OSCEN bit is checked for the 'enabled' status. If the OSCEN bit is enabled and the oscillator is not active



within the first 5 ms, the OSCF bit is set to '1'. The system must check for this condition and then write '0' to clear the flag.

Note that in addition to setting the OSCF flag bit, the time registers are reset to the 'Base Time', which is the value last written to the timekeeping registers. The control or calibration registers and the OSCEN bit are not affected by the 'oscillator failed' condition.

The value of OSCF must be reset to '0' when the time registers are written for the first time. This initializes the state of this bit which may have become set when the system was first powered on.

To reset OSCF, set the write bit 'W' (in the flags register at 0x7FF0) to a '1' to enable writes to the flags register . Write a '0' to the OSCF bit and then reset the write bit to '0' to disable writes.

Calibrating the Clock

The RTC is driven by a quartz controlled crystal with a nominal frequency of 32.768 kHz. Clock accuracy depends on the quality of the crystal and calibration. The crystals available in market typically have an error of \pm 20 ppm to \pm 35 ppm. However, CY14B256KA employs a calibration circuit that improves the accuracy to +1/–2 ppm at 25 °C. This implies an error of +2.5 seconds to –5 seconds per month.

The calibration circuit adds or subtracts counts from the oscillator divider circuit to achieve this accuracy. The number of pulses that are suppressed (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in Calibration register at 0x7FF8. The calibration bits occupy the five lower order bits in the Calibration register. These bits are set to represent any value between '0' and 31 in binary form. Bit D5 is a sign bit, where a '1' indicates positive calibration and a '0' indicates negative calibration. Adding counts speeds the clock up and subtracting counts slows the clock down. If a binary '1' is loaded into the register, it corresponds to an adjustment of 4.068 or -2.034 ppm offset in oscillator error, depending on the sign.

Calibration occurs within a 64-minute cycle. The first 62 minutes in the cycle may, once every minute, have one second shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first two minutes of the 64-minute cycle are modified. If a binary 6 is loaded, the first 12 are affected, and so on. Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is, 4.068 or –2.034 ppm of adjustment per calibration step in the Calibration register.

To determine the required calibration, the CAL bit in the flags register (0x7FF0) must be set to '1'. This causes the INT pin to toggle at a nominal frequency of 512 Hz. Any deviation measured from the 512 Hz indicates the degree and direction of the required correction. For example, a reading of 512.01024 Hz indicates a +20 ppm error. Hence, a decimal value of -10 (001010b) must be loaded into the Calibration register to offset this error.

Note Setting or changing the Calibration register does not affect the test output frequency.

To set or clear CAL, set the write bit 'W' (in the flags register at 0x7FF0) to '1' to enable writes to the flags register . Write a value to CAL, and then reset the write bit to '0' to disable writes.

Alarm

The alarm function compares user programmed values of alarm time and date (stored in the registers 0x7FF1-5) with the corresponding time of day and date values. When a match occurs, the alarm internal flag (AF) is set and an interrupt is generated on INT pin if Alarm Interrupt Enable (AIE) bit is set.

There are four alarm match fields – date, hours, minutes, and seconds. Each of these fields has a match bit that is used to determine if the field is used in the alarm match logic. Setting the match bit to '0' indicates that the corresponding field is used in the match process. Depending on the match bits, the alarm occurs as specifically as once a month or as frequently as once every minute. Selecting none of the match bits (all 1s) indicates that no match is required and therefore, alarm is disabled. Selecting all match bits (all 0s) causes an exact time and date match.

There are two ways to detect an alarm event: by reading the AF flag or monitoring the INT pin. The AF flag in the flags register at 0x7FF0 indicates that a date or time match has occurred. The AF bit is set to '1' when a match occurs. Reading the flags register clears the alarm flag bit (and all others). A hardware interrupt pin may also be used to detect an alarm event.

To set, clear or enable an alarm, set the 'W' bit (in flags register -0x7FF0) to '1' to enable writes to Alarm Registers. After writing the alarm value, clear the 'W' bit back to '0' for the changes to take effect.

Note CY14B256KA requires the alarm match bit for seconds (bit 'D7' in Alarm-Seconds register 0x7FF2) to be set to '0' for proper operation of Alarm Flag and Interrupt..

Watchdog Timer

The watchdog timer is a free running down counter that uses the 32 Hz clock (31.25 ms) derived from the crystal oscillator. The oscillator must be running for the watchdog to function. It begins counting down from the value loaded in the watchdog timer register.

The timer consists of a loadable register and a free running counter. On power-up, the watchdog time out value in register 0x7FF7 is loaded into the counter load register. Counting begins on power-up and restarts from the loadable value any time the watchdog strobe (WDS) bit is set to '1'. The counter is compared to the terminal value of '0'. If the counter reaches this value, it causes an internal flag and an optional interrupt output. You can prevent the time out interrupt by setting WDS bit to '1' prior to the counter reaching '0'. This causes the counter to reload with the watchdog time out value and to be restarted. As long as the user sets the WDS bit prior to the counter reaching the terminal value, the interrupt and WDT flag never occur.

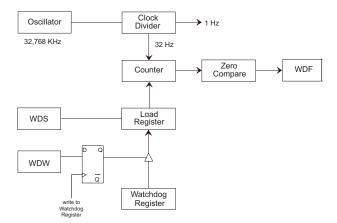
New time out values are written by setting the watchdog write bit to '0'. When the WDW is '0', new writes to the watchdog time out value bits D5–D0 are enabled to modify the time out value. When WDW is '1', writes to bits D5–D0 are ignored. The WDW function enables a user to set the WDS bit without concern that the watchdog timer value is modified. A logical diagram of the watchdog timer is shown in Figure 3. Note that setting the watchdog time out value to '0' disables the watchdog function.

The output of the watchdog timer is the flag bit WDF that is set if the watchdog is allowed to time out. If the watchdog interrupt enable (WIE) bit in the interrupt register is set, a hardware



interrupt on INT pin is also generated on watchdog timeout. The flag and the hardware interrupt are both cleared when user reads the flags register.

Figure 3. Watchdog Timer Block Diagram



Power Monitor

The CY14B256KA provides a power management scheme with power fail interrupt capability. It also controls the internal switch to backup power for the clock and protects the memory from low V_{CC} access. The power monitor is based on an internal band gap reference circuit that compares the V_{CC} voltage to V_{SWITCH} threshold.

As described in the AutoStore Operation on page 4, when V_{SWITCH} is reached as V_{CC} decays from power loss, a data STORE operation is initiated from SRAM to the nonvolatile elements, securing the last SRAM data state. Power is also switched from V_{CC} to the backup supply (battery or capacitor) to operate the RTC oscillator.

When operating from the backup source, read and write operations to nvSRAM are inhibited and the RTC functions are not available to the user. The RTC clock continues to operate in the background. The updated RTC time keeping registers data are available to the user after V_{CC} is restored to the device (see AutoStore/Power-Up RECALL on page 21).

Interrupts

The CY14B256KA has flags register, interrupt register and interrupt logic that can signal interrupt to the microcontroller. There are three potential sources for interrupt: watchdog timer, power monitor, and alarm timer. Each of these can be individually enabled to drive the INT pin by appropriate setting in the interrupt register (0x7FF6). In addition, each has an associated flag bit in the flags register (0x7FF0) that the host processor uses to determine the cause of the interrupt. The INT pin driver has two bits that specify its behavior when an interrupt occurs.

An interrupt is raised only if both a flag is raised by one of the three sources and the respective interrupt enable bit in interrupts register is enabled (set to '1'). After an interrupt source is active, two programmable bits, H/L and P/L, determine the behavior of the output pin driver on INT pin. These two bits are located in the interrupt register and can be used to drive level or pulse mode output from the INT pin. In pulse mode, the pulse width is

internally fixed at approximately 200 ms. This mode is intended to reset a host microcontroller. In the level mode, the pin goes to its active polarity until the flags register is read by the user. This mode is used as an interrupt to a host microcontroller. The control bits are summarized in the following section.

Interrupts are only generated while working on normal power and are not triggered when system is running in backup power mode.

Note CY14B256KA generates valid interrupts only after the Powerup RECALL sequence is completed. All events on INT pin must be ignored for $t_{HRECALL}$ duration after powerup.

Interrupt Register

Watchdog Interrupt Enable (WIE). When set to '1', the watchdog timer drives the INT pin and an internal flag when a watchdog time out occurs. When WIE is set to '0', the watchdog timer only affects the WDF flag in flags register.

Alarm Interrupt Enable (AIE). When set to '1', the alarm match drives the INT pin and an internal flag. When AIE is set to '0', the alarm match only affects the AF flag in flags register.

Power Fail Interrupt Enable (PFE). When set to '1', the power fail monitor drives the pin and an internal flag. When PFE is set to '0', the power fail monitor only affects the PF flag in flags register.

High/Low (H/L). When set to a '1', the INT pin is active HIGH and the driver mode is push pull. The INT pin drives high only when V_{CC} is greater than V_{SWITCH} . When set to a '0', the INT pin is active LOW and the drive mode is open drain. The INT pin must be pulled up to Vcc by a 10 k resistor while using the interrupt in active LOW mode.

Pulse/Level (P/L). When set to a '1' and an interrupt occurs, the INT pin is driven for approximately 200 ms. When P/L is set to a '0', the INT pin is driven high or low (determined by H/L) until the flags register is read.

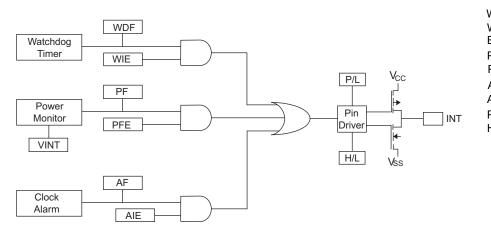
When an enabled interrupt source activates the INT pin, an external host reads the flags register to determine the cause. All flags are cleared when the register is read. If the INT pin is programmed for level mode, then the condition clears and the INT pin returns to its inactive state. If the pin is programmed for pulse mode, then reading the flag also clears the flag and the pin. The pulse does not complete its specified duration if the flags register is read. If the INT pin is used as a host reset, then the flags register is not read during a reset.

Flags Register

The flags register has three flag bits: WDF, AF, and PF, which can be used to generate an interrupt. These flags are set by the watchdog timeout, alarm match, or power fail monitor respectively. The processor can either poll this register or enable interrupts to be informed when a flag is set. These flags are automatically reset when the register is read. The flags register is automatically loaded with the value 0x00 on power-up (except for the OSCF bit; see Stopping and Starting the Oscillator on page 7).



Figure 4. Interrupt Block Diagram



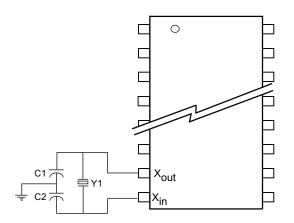
WDF - Watchdog Timer Flag WIE - Watchdog Interrupt Enable PF - Power Fail Flag PFE - Power Fail Enable AF - Alarm Flag AIE - Alarm Interrupt Enable P/L - Pulse Level H/L - High/Low

RTC External Components

The RTC requires connecting an external 32.768 kHz crystal and C₁, C₂ load capacitance as shown in the Figure 5. The figure shows the recommnded RTC external component values. The

load capacitances C_1 and C_2 are inclusive of parasitic of the printed circuit board (PCB). The PCB parasitic includes the capacitance due to land pattern of crystal pads/pins, X_{in}/X_{out} pads and copper traces connecting crystal and device pins.

Figure 5. RTC Recommended Component Configuration ^[5]



Recommended Values

 $Y_1 = 32.768 \text{ kHz} (12.5 \text{ pF})$ $C_1 = 10 \text{ pF}$ $C_2 = 67 \text{ pF}$

Note: The recommended values for C1 and C2 include board trace capacitance.

Note

5. For nonvolatile static random access memory (nvSRAM) real time clock (RTC) design guidelines and best practices, see application note AN61546.



PCB Design Considerations for RTC

RTC crystal oscillator is a low current circuit with high impedance nodes on their crystal pins. Due to lower timekeeping current of RTC, the crystal connections are very sensitive to noise on the board. Hence it is necessary to isolate the RTC circuit from other signals on the board.

It is also critical to minimize the stray capacitance on the PCB. Stray capacitances add to the overall crystal load capacitance and therefore cause oscillation frequency errors. Proper bypassing and careful layout are required to achieve the optimum RTC performance.

Layout requirements

The board layout must adhere to (but not limited to) the following guidelines during routing RTC circuitry. Following these guidelines help you achieve optimum performance from the RTC design.

It is important to place the crystal as close as possible to the X_{in} and X_{out} pins. Keep the trace lengths between the crystal and RTC equal in length and as short as possible to reduce the probability of noise coupling by reducing the length of the antenna.

- Keep X_{in} and X_{out} trace width lesser than 8 mils. Wider trace width leads to larger trace capacitance. The larger these bond pads and traces are, the more likely it is that noise can couple from adjacent signals.
- Shield the X_{in} and X_{out} signals by providing a guard ring around the crystal circuitry. This guard ring prevents noise coupling from neighboring signals.
- Take care while routing any other high speed signal in the vicinity of RTC traces. The more the crystal is isolated from other signals on the board, the less likely it is that noise is coupled into the crystal. Maintain a minimum of 200 mil separation between the X_{in}, X_{out} traces and any other high speed signal on the board.
- No signals should run underneath crystal components on the same PCB layer.

Create an isolated solid copper plane on adjacent PCB layer and underneath the crystal circuitry to prevent unwanted noise coupled from traces routed on the other signal layers of the PCB. The local plane should be separated by at least 40 mils from the neighboring plane on the same PCB layer. The solid plane should be in the vicinity of RTC components only and its perimeter should be kept equal to the guard ring perimeter. Figure 6 shows the recommended layout for RTC circuit.

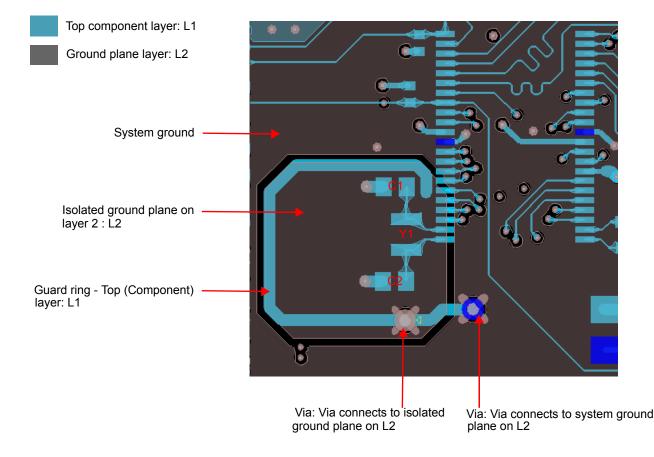


Figure 6. Recommended Layout for RTC



 Table 3. RTC Register Map [6, 7]

Register			BCD Form	nat Data ^[6]				Function/Range	
CY14B256KA	D7	D6	D5	D4	D3	D2	D1	D0	Function/Kange
0x7FFF		10s y	ears			Ye	ears		Years: 00–99
0x7FFE	0	0	0	10s months		Мс	onths		Months: 01–12
0x7FFD	0	0	10s day	of month		Day o	f month		Day of month: 01–31
0x7FFC	0	0	0	0	0		Day of w	/eek	Day of week: 01–07
0x7FFB	0	0	10s	hours		Ho	ours		Hours: 00–23
0x7FFA	0		10s minut	tes		Mir	nutes		Minutes: 00–59
0x7FF9	0	1	0s secor	nds		Sec	conds		Seconds: 00–59
0x7FF8	OSCEN (0)	0	Cal sign (0)		Calib	ration (00	0000)		Calibration values ^[8]
0x7FF7	WDS (0)	WDW (0)			WDT (0	00000)			Watchdog ^[8]
0x7FF6	WIE (0)	AIE (0)	PFE (0)	0	H/L (1)	P/L (0)	0	0	Interrupts [8]
0x7FF5	M (1)	0	10s al	arm date		Alar	m day		Alarm, Day of month: 01–31
0x7FF4	M (1)	0	10s ala	arm hours		Alarn	n hours		Alarm, hours: 00–23
0x7FF3	M (1)	10s	alarm m	inutes	Alarm minutes			Alarm, minutes: 00–59	
0x7FF2	M (1)	10s	alarm se	conds	Alarm, seconds			Alarm, seconds: 00–59	
0x7FF1		10s cer	nturies			Centuries			Centuries: 00–99
0x7FF0	WDF	AF	PF	OSCF ^[9]	0	CAL (0)	W (0)	R (0)	Flags ^[8]

Notes

The unused bits of RTC registers are reserved for future use and should be set to '0'.
 () designates values shipped from the factory.
 This is a binary value, not a BCD value.
 When the user resets OSCF flag bit, the flags register will be updated after t_{RTCp} time.



Table 4. Register Map Detail

Register		Description								
Y14B256KA										
0x7FFF				Time Keepir						
	D7	D6	D5	D4	D3	D2	D1	D0		
	10s years Years									
	Contains the lower two BCD digits of the year. Lower nibble (four bits) contains the value for years; upper nibble (four bits) contains the value for 10s of years. Each nibble operates from 0 to 9. The range for the register is 0–99									
0x7FFE				Time Keeping	-					
	D7	D6	D5	D4	D3	D2	D1	D0		
	0	0	0	10s month			onths			
	-	, i i i i i i i i i i i i i i i i i i i	-	ower nibble (four	bits) contain			es from 0 to		
				digit and operat						
				Time Keepi	ng - Date					
0x7FFD	D7	D6	D5	D4	D3	D2	D1	D0		
	0	0	10s day	of month		Day o	of month			
	from 0 to 9;	Contains the BCD digits for the date of the month. Lower nibble (four bits) contains the lower digit and operates from 0 to 9; upper nibble (two bits) contains the 10s digit and operates from 0 to 3. The range for the register is 1–31. Leap years are automatically adjusted for.								
	Time Keeping - Day									
0.7550				Time Keepi	ing - Day					
0x7FFC	D7	D6	D5	D4	D3	D2	D1	D0		
0x7FFC	0	0	0	D4 0	D3 0		Day of week			
0x7FFC	0 Lower nibble	0 e (three bits) c rom 1 to 7 the	0 ontains a valu	D4 0 e that correlates The user must as	D3 0 to day of the ssign meanin	e week. Day o	Day of week of the week is	a ring cour		
0x7FFC 0x7FFB	0 Lower nibble that counts f integrated w	0 e (three bits) c rom 1 to 7 the ith the date.	0 ontains a valu n returns to 1.	D4 0 e that correlates The user must as Time Keepin	D3 0 to day of the ssign meanin ng - Hours	e week. Day o g to the day v	Day of week of the week is value, because	a ring cour the day is		
	0 Lower nibble that counts f integrated w D7	0 e (three bits) c rom 1 to 7 the ith the date. D6	0 ontains a valu n returns to 1. D5	D4 0 e that correlates The user must as Time Keepin D4	D3 0 to day of the ssign meanin	e week. Day o g to the day v D2	Day of week of the week is value, because	a ring cour		
	0 Lower nibble that counts f integrated w D7 0	0 e (three bits) c rom 1 to 7 the ith the date. D6 0	0 ontains a valu n returns to 1. D5 10s	D4 0 e that correlates The user must as Time Keepin D4 hours	D3 0 to day of the ssign meanin ng - Hours D3	e week. Day o ig to the day v D2	Day of week of the week is value, because D1 ours	a ring cour e the day is D0		
	0 Lower nibble that counts f integrated w D7 0 Contains the	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 BCD value of	0 ontains a valu n returns to 1. D5 10s hours in 24 ho	D4 0 e that correlates The user must as Time Keepin D4 hours pur format. Lower ins the upper dig	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and opera	e week. Day o g to the day v D2 Ho bits) contains	Day of week of the week is value, because D1 ours the lower digi	a ring cour e the day is D0 t and opera		
0x7FFB	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23.	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 e BCD value of upper nibble (0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta	D4 0 e that correlates The user must as Time Keepin D4 hours pur format. Lower ins the upper dig Time Keeping	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and opera	e week. Day o g to the day v D2 Ho bits) contains	Day of week of the week is value, because D1 ours the lower digi 2. The range	a ring cour e the day is D0 t and opera		
	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23.	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 BCD value of	0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta	D4 0 e that correlates The user must as Time Keepin D4 hours our format. Lower ins the upper dig Time Keeping D4	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and opera	e week. Day o og to the day v D2 Ho bits) contains tes from 0 to D2	Day of week of the week is value, because D1 ours the lower digi 2. The range	a ring cour e the day is D0 t and opera		
0x7FFB	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23.	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 e BCD value of upper nibble (0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta	D4 0 e that correlates The user must as Time Keepin D4 hours our format. Lower ins the upper dig Time Keeping D4	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and opera	e week. Day o og to the day v D2 Ho bits) contains tes from 0 to D2	Day of week of the week is value, because D1 ours the lower digi 2. The range	a ring cour the day is D0 t and opera for the regis		
0x7FFB	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23. D7 0 Contains the	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 e BCD value of upper nibble (D6 e BCD value of	0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta D5 10s minutes f minutes. Lov	D4 0 e that correlates The user must as Time Keepin D4 hours our format. Lower ins the upper dig Time Keeping D4	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and opera g - Minutes D3 D3	e week. Day o g to the day v D2 He bits) contains tes from 0 to D2 Mir the lower dig	Day of week of the week is value, because D1 ours the lower digi 2. The range the D1 nutes git and operate	a ring cour the day is D0 t and opera for the regis D0 es from 0 to		
0x7FFB 0x7FFA	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23. D7 0 Contains the upper nibble	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 e BCD value of upper nibble (D6 e BCD value of	0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta D5 10s minutes f minutes. Lov	D4 0 e that correlates The user must as Time Keepin D4 hours pur format. Lower ins the upper dig Time Keeping D4 hours our format. Lower ins the upper dig D4 ver nibble (four b	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and operat g - Minutes D3 D3 D3	e week. Day o g to the day v D2 He bits) contains tes from 0 to D2 Mir the lower dig	Day of week of the week is value, because D1 ours the lower digi 2. The range the D1 nutes git and operate	a ring cour the day is D0 t and opera for the regis D0 es from 0 to		
0x7FFB	0 Lower nibble that counts f integrated w D7 0 Contains the from 0 to 9; is 0–23. D7 0 Contains the upper nibble	0 e (three bits) c rom 1 to 7 the ith the date. D6 0 e BCD value of upper nibble (D6 e BCD value of	0 ontains a valu n returns to 1. D5 10s hours in 24 ho two bits) conta D5 10s minutes f minutes. Lov	D4 0 e that correlates The user must as Time Keepin D4 hours pur format. Lower ins the upper dig Time Keeping D4 wer nibble (four boer minutes digit	D3 0 to day of the ssign meanin ng - Hours D3 r nibble (four git and operat g - Minutes D3 D3 D3	e week. Day o g to the day v D2 He bits) contains tes from 0 to D2 Mir the lower dig	Day of week of the week is value, because D1 ours the lower digi 2. The range the D1 nutes git and operate	a ring cour the day is D0 t and opera for the regis D0 es from 0 to		



Table 4. Register Map Detail (continued)

Register		Description								
CY14B256KA	Description									
0x7FF8	Calibration/Control									
	D7	D6	D5	D4	D3	D2	D1	D0		
	OSCEN	0	Calibration sign			Calibration				
OSCEN			et to '1', the os capacitor powe			et to '0', the c	oscillator runs	. Disabling the		
Calibration Sign	Determines i	Determines if the calibration adjustment is applied as an addition (1) to or as a subtraction (0) from the time-base.								
Calibration	These five b	its control the	calibration of th	ne clock.						
0x7FF7				WatchDo	g Timer					
UX/FF/	D7	D6	D5	D4	D3	D2	D1	D0		
	WDS	WDW			W	DT	•			
WDS			his bit to '1' relo ically after the							
WDW	allows the us bits D5–D0 to	ser to set the v o be written to	etting this bit to watchdog strob the watchdog re Timer on page	e bit without d egister when th	sturbing the	timeout value	. Setting this	bit to '0' allows		
WDT	represents a 2 seconds (s	multiplier of the setting of 3 Fh)	on. The watch ne 32 Hz count . Setting the wa et to 0 on a prev	(31.25 ms). Th atchdog timer r	ne range of tir	meout value is	s 31.25 ms (a	setting of 1) to		
0x7FF6				Interrupt Sta	tus/Control					
UXTEFO	D7	D6	D5	D4	D3	D2	D1	D0		
	WIE	AIE	PFE	0	H/L	P/L	0	0		
WIE			. When set to ' en set to '0', the					drives the IN		
AIE		ipt enable. Wh only affects th	nen set to '1', th ne AF flag.	e alarm match	drives the IN	IT pin and the	AF flag. Whe	en set to '0', the		
PFE			et to '1', the pov only the PF flag		drives the IN	IT pin and the	PF flag. Whe	en set to '0', the		
0	Reserved for	r future use								
H/L	High/Low. W	hen set to '1', t	he INT pin is dri	ven active HIG	H. When set t	o '0', the INT p	in is open dra	in, active LOW		
P/L		ly 200 ms. W	'1', the INT p hen set to '0', t							
0x7FF5				Alarm	- Day					
•••••	D7	D6	D5	D4	D3	D2	D1	D0		
	М	0	10s ala	rm date		Alar	m date			
	Contains the	alarm value f	or the date of the	ne month and t	he mask bit t	o select or de	select the da	te value.		
М		n this bit is set ore the date va	to '0', the date v	alue is used in	the alarm ma	atch. Setting th	nis bit to '1' ca	uses the matcl		



Table 4. Register Map Detail (continued)

Register CY14B256KA	- Description									
0×7554	Alarm - Hours									
0x7FF4	D7	D6	D5	D4	D3	D2	D1	D0		
	М	0	10s alaı	rm hours		Alarn	n hours			
	Contains the	Contains the alarm value for the hours and the mask bit to select or deselect the hours value.								
М		Match. When this bit is set to '0', the hours value is used in the alarm match. Setting this bit to '1' causes the match circuit to ignore the hours value.								
0x7FF3				Alarm - I	Vinutes					
0,7110	D7	D6	D5	D4	D3	D2	D1	D0		
	М	1	0s alarm minut	tes		Alarm	minutes			
	Contains the	alarm value f	or the minutes	and the mask I	bit to select or	deselect the	minutes value	e.		
М			to '0', the mini minutes value.	utes value is us	ed in the alar	m match. Set	ting this bit to	'1' causes th		
0~7550				Alarm - S	econds					
0x7FF2	D7	D6	D5	D4	D3	D2	D1	D0		
	М	1	0s alarm secor	nds		Alarm	seconds			
	Contains the	alarm value f	or the seconds	and the mask	bit to select o	r deselect the	seconds' val	ue.		
М			to '0', the seco seconds value	onds value is us	sed in the alar	m match. Set	ting this bit to	'1' causes th		
0	Time Keeping - Centuries									
0x7FF1	D7	D6	D5	D4	D3	D2	D1	D0		
		10s c	enturies			Cen	ituries			
	Contains the upper nibble centuries.	BCD value o (four bits) co	f centuries. Lov ntains the upp	wer nibble (four er digit and op	bits) contains erates from 0	the lower dig to 9. The ra	git and operat nge for the re	es from 0 to egister is 0–9		
0x7FF0				Fla	gs					
0,7110	D7	D6	D5	D4	D3	D2	D1	D0		
	WDF	AF	PF	OSCF	0	CAL	W	R		
WDF				set to '1' when the flags regis			ved to reach () without beir		
AF	with the mate	ch bits = 0. It i	s cleared wher	when the time an the flags regis	ster is read or	on power-up.		· ·		
PF	Power fail fla to 0 when th	ig. This read o e flags registe	nly bit is set to r r is read or on	1 when power fa power-up.	alls below the	power fail thre	eshold V _{SWITO}	_{CH} . It is cleare		
OSCF	This indicate and is never	s that RTC ba cleared intern	ckup power fai ally by the chip	if the oscillator i led and clock va o. The user mus vill be updated	alue is no long st check for th	er valid. This is condition a	bit survives th	ne power cyc		
CAL		When user resets OSCF flag bit, the bit will be updated after t _{RTCp} time. Calibration mode. When set to '1', a 512 Hz square wave is output on the INT pin. When set to '0', the INT pin resumes normal operation. This bit defaults to 0 (disabled) on power-up.								
W	registers, ala the contents	arm registers, of the RTC re	calibration regised agisters to be to	eezes updates ster, interrupt re ransferred to th plete. This bit d	egister and flag	gs register. Se ig counters if	etting the 'W' b	oit to '0' cause		
R	during the re	ading process	. Set 'R' bit to '	lock updates to 0' to resume clo defaults to 0 o	ock updates to					



Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. These user guidelines are not tested.

Storage temperature65 °C to +150 °C
Maximum accumulated storage time
At 150 °C ambient temperature 1000 h
At 85 °C ambient temperature 20 Years
Maximum junction temperature150 °C
Supply voltage on V_{CC} relative to V_{SS} –0.5 V to 4.1 V
Voltage applied to outputs
in High Z state–0.5 V to V_{CC} + 0.5 V
Input voltage–0.5 V to V $_{CC}$ + 0.5 V

Transient voltage (< 20 ns) on any pin to ground potential–2.0 V to V_{CC} + 2.0 V
Package power dissipation capability (T _A = 25 $^{\circ}$ C) 1.0 W
Surface mount Pb soldering temperature (3 seconds)+260 °C
DC output current (1 output at a time, 1s duration) 15 mA
Static discharge voltage (per MIL-STD-883, Method 3015) > 2001 V
Latch up current > 200 mA

Operating Range

Range	Ambient Temperature	V _{cc}
Industrial	–40 °C to +85 °C	2.7 V to 3.6 V

DC Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditions	Min	Typ ^[10]	Max	Unit
V _{CC}	Power supply voltage		2.7	3.0	3.6	V
I _{CC1}	Average V _{cc} current	t_{RC} = 25 ns t_{RC} = 45 ns Values obtained without output loads (I _{OUT} = 0 mA)	_	-	70 52	mA mA
I _{CC2}	Average V _{CC} current during STORE	All inputs don't care, V_{CC} = Max. Average current for duration t_{STORE}	-	-	10	mA
I _{CC3} ^[10]	Average V _{CC} current at t _{RC} = 200 ns, V _{CC(Typ)} , 25 °C	All inputs cycling at CMOS levels. Values obtained without output loads (I _{OUT} = 0 mA).	-	35	_	mA
I _{CC4}	Average V _{CAP} current during All inputs don't care. Average current – AutoStore cycle for duration t _{STORE} –		_	-	5	mA
I _{SB}	V _{CC} standby current	$\begin{array}{l} CE \geq (V_{CC}-0.2 \ V). \\ V_{IN} \leq 0.2 \ V \ or \geq (V_{CC}-0.2 \ V). \\ W \ bit \ set \ to \ '0'. \\ Standby \ current \ level \ after \\ nonvolatile \ cycle \ is \ complete. \\ Inputs \ are \ static. \ f = 0 \ MHz. \end{array}$	_	_	5	mA
I _{IX} ^[11]	Input leakage current (except HSB)	V_{CC} = Max, $V_{SS} \le V_{IN} \le V_{CC}$	-1	-	+1	μA
	Input leakage current (for HSB)	V_{CC} = Max, $V_{SS} \le V_{IN} \le V_{CC}$	-100	_	+1	μA
I _{OZ}	Off state output leakage current	$\frac{V_{CC}}{CE} = \underline{Max}, V_{SS} \leq \underline{V_{OUT}} \leq V_{CC},$ CE or OE $\geq V_{IH}$ or WE $\leq V_{IL}$	-1	-	+1	μA
V _{IH}	Input HIGH voltage		2.0	-	V _{CC} + 0.5	V
V _{IL}	Input LOW voltage		$V_{\rm SS} - 0.5$	_	0.8	V
V _{OH}	Output HIGH voltage	I _{OUT} = –2 mA	2.4	_	_	V
V _{OL}	Output LOW voltage	I _{OUT} = 4 mA	-	-	0.4	V

Notes
 10. Typi<u>cal values are at 25 °C</u>, V_{CC} = V_{CC(Typ)}. Not 100% tested.
 11. The HSB pin has I_{OUT} = -2 μA for V_{OH} of 2.4 V when both active HIGH and low drivers are disabled. When they are enabled standard V_{OH} and V_{OL} are valid. This parameter is characterized but not tested.



DC Electrical Characteristics (continued)

Over the Operating Range

Parameter	Description	Test Conditions	Min	Typ ^[10]	Max	Unit
V _{CAP} ^[12]	Storage capacitor	Between V_{CAP} pin and V_{SS}	61	68	180	μF
	Maximum voltage driven on $V_{\mbox{CAP}}$ pin by the device	V _{CC} = Max	_	_	V _{CC}	V

Data Retention and Endurance

Over the Operating Range

Parameter	Description	Min	Unit
DATA _R	Data retention	20	Years
NV _C	Nonvolatile STORE operations	1,000	К

Capacitance

Parameter ^[14]	Description	Test Conditions	Max	Unit
C _{IN}	Input capacitance (except HSB)	$T_A = 25 \text{ °C}, f = 1 \text{ MHz}, V_{CC} = V_{CC(Typ)}$	7	pF
	Input capacitance (for HSB)		8	pF
C _{OUT}	Output capacitance (except HSB)		7	pF
	Output capacitance (for HSB)		8	pF

Thermal Resistance

Parameter ^[14]	Description	Test Conditions	48-pin SSOP	Unit
Θ_{JA}	(Test conditions follow standard test methods and procedures for measuring thermal impedance, in		°C/W
Θ^{JC}	Thermal resistance (Junction to case)	accordance with EIA/JESD51.	24.71	°C/W

Notes

14. These parameters are guaranteed by design and are not tested.

^{12.} Min V_{CAP} value guarantees that there is a sufficient charge available to complete a successful AutoStore operation. Max V_{CAP} value guarantees that the capacitor on V_{CAP} is charged to a minimum voltage during a Power-Up RECALL cycle so that an immediate power-down cycle can complete a successful AutoStore. Therefore it is always recommended to use a capacitor within the specified min and max limits. Refer application note AN43593 for more details on V_{CAP} options.

^{13.} Maximum voltage on V_{CAP} pin (V_{VCAP}) is provided for guidance when choosing the V_{CAP} capacitor. The voltage rating of the V_{CAP} capacitor across the operating temperature range should be higher than the V_{VCAP} voltage.



AC Test Loads

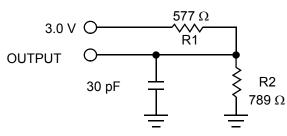


Figure 7. AC Test Loads 577 Ω 3.0 V O /// R1 OUTPUT С R2 5 pF **789** Ω

AC Test Conditions

Input pulse levels	0 V to 3 V
Input rise and fall times (10%–90%)	<u><</u> 3 ns
Input and output timing reference levels	1.5 V

RTC Characteristics

Over the Operating Range

Parameter	Description	Min	Typ ^[15]	Мах	Units	
V _{RTCbat}	RTC battery pin voltage		1.8	3.0	3.6	V
I _{BAK} ^[16]	RTC backup current	T _A (Min)	-	-	0.35	μA
	(Refer Figure 5 for the recommended external componets for RTC)	25 °C	-	0.35	-	μA
		T _A (Max)	-	-	0.5	μA
V _{RTCcap} ^[17]	RTC capacitor pin voltage	T _A (Min)	1.6	-	3.6	V
		25 °C	1.5	3.0	3.6	V
		T _A (Max)	1.4	_	3.6	V
t _{ocs}	RTC oscillator time to start	•	-	1	2	sec
t _{RTCp}	RTC processing time from end of 'W' bit set to '0'		-	-	350	μS
R _{BKCHG}	RTC backup capacitor charge current-limiting resistor		350	-	850	Ω

Notes

15. Typical values are at 25 °C, $V_{CC} = V_{CC(Typ)}$. Not 100% tested.

16. From either V_{RTCcap} or V_{RTCbat}.
17. If V_{RTCcap} > 0.5 V or if no capacitor is connected to V_{RTCcap} pin, the oscillator starts in t_{OCS} time. If a backup capacitor is connected and V_{RTCcap} < 0.5 V, the capacitor must be allowed to charge to 0.5 V for oscillator to start.

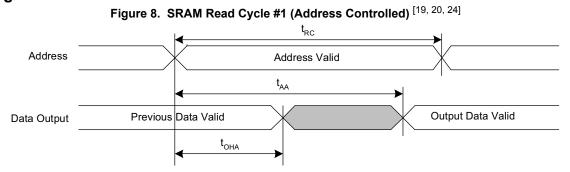


AC Switching Characteristics

Over the Operating Range

Param	eters ^[18]		25	ns	45 ns		
Cypress Parameter Alt Parameter		Description	Min	Max	Min	Мах	Unit
SRAM Read	Ċycle						
t _{ACE}	t _{ACS}	Chip enable access time	-	25	-	45	ns
t _{RC} ^[19]	t _{RC}	Read cycle time	25	-	45	-	ns
t _{AA} ^[20]	t _{AA}	Address access time	-	25	-	45	ns
t _{DOE}	t _{OE}	Output enable to data valid	_	12	-	20	ns
t _{она} [20]	t _{OH}	Output hold after address change	3	-	3	-	ns
t _{LZCE} ^[21, 22]	t _{LZ}	Chip enable to output active	3	-	3	-	ns
t _{HZCE} ^[21, 22]	t _{HZ}	Chip disable to output Inactive	-	10	-	15	ns
t _{I ZOF} ^[21, 22]	t _{OLZ}	Output enable to output active	0	-	0	-	ns
t _{HZOE} ^[21, 22]	t _{онz}	Output disable to output inactive	-	10	-	15	ns
t _{PU} ^[21]	t _{PA}	Chip enable to power active	0	-	0	-	ns
t _{PD} ^[21]	t _{PS}	Chip disable to power standby	-	25	-	45	ns
SRAM Write	Cycle						
t _{WC}	t _{WC}	Write cycle time	25	-	45	-	ns
t _{PWE}	t _{WP}	Write pulse width	20	-	30	-	ns
t _{SCE}	t _{CW}	Chip enable to end of write	20	-	30	-	ns
t _{SD}	t _{DW}	Data setup to end of write	10	-	15	-	ns
t _{HD}	t _{DH}	Data hold after end of write	0	-	0	-	ns
t _{AW}	t _{AW}	Address setup to end of write	20	-	30	-	ns
t _{SA}	t _{AS}	Address setup to start of write	0	-	0	-	ns
t _{HA}	t _{WR}	Address hold after end of write	0	-	0	-	ns
t _{HZWE} [21, 22, 23]	t _{WZ}	Write enable to output disable	-	10	-	15	ns
t _{LZWE} ^[21, 22]	t _{OW}	Output active after end of write	3	_	3	_	ns

Switching Waveforms



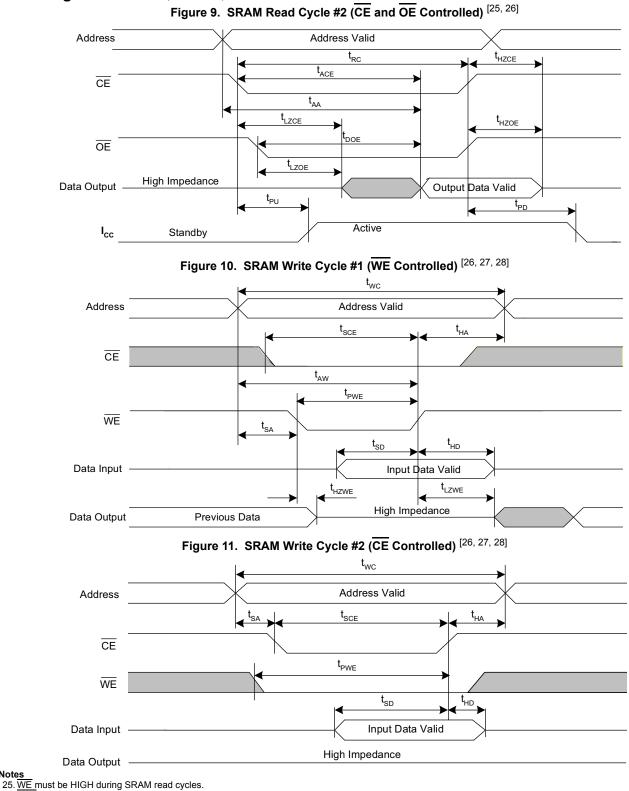
Notes

- 18. Test conditions assume signal transition time of 3 ns or less, timing reference levels of V_{CC}/2, input pulse levels of 0 to V_{CC(typ)}, and output loading of the specified log/l_{OH} and load capacitance shown in Figure 7 on page 18.
 19. WE must be HIGH during SRAM read cycles.
 20. Device is continuously selected with CE and OE LOW.

- 21. These parameters are guaranteed by design and are not tested.
 22. Measured ±200 mV from steady state output voltage.
 23. If WE is low when CE goes low, the outputs remain in the high impedance state.
 24. HSB must remain HIGH during Read and Write cycles.



Switching Waveforms (continued)



Notes

26. HSB must remain HIGH during Read and Write cycles. 27. If WE is low when CE goes low, the outputs remain in the high impedance state. 28. CE or WE must be $\geq V_{IH}$ during address transitions.

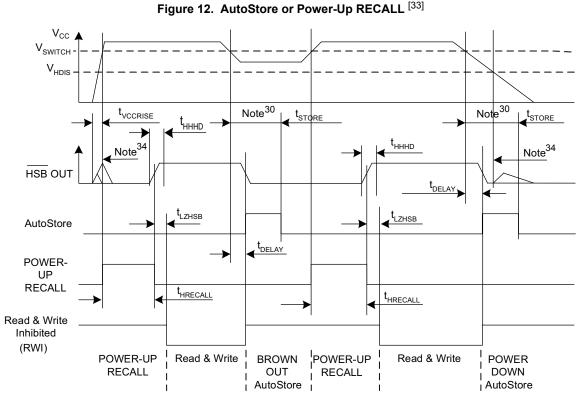


AutoStore/Power-Up RECALL

Over the Operating Range

Parameter	Description	Min	Max	Unit
t _{HRECALL} ^[29]	Power-Up RECALL duration	-	20	ms
t _{STORE} ^[30]	STORE cycle duration	-	8	ms
t _{DELAY} ^[31]	Time allowed to complete SRAM write cycle	-	25	ns
V _{SWITCH}	Low voltage trigger level	-	2.65	V
t _{VCCRISE} [32]	V _{CC} rise time	150	-	μs
V _{HDIS} ^[32]	HSB output disable voltage	-	1.9	V
t _{LZHSB} ^[32]	HSB to output active time	-	5	μs
t _{HHHD} ^[32]	HSB high active time	-	500	ns

Switching Waveforms



Notes

- 49. t_{HRECALL} starts from the time V_{CC} rises above V_{SWICH}.
 30. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place
- 31. On a Hardware STORE and AutoStore initiation, SRAM write operation continues to be enabled for time t_{DELAY}

32. These parameters are guaranteed by design and are not tested.

- 33. Read and Write cycles are ignored during STORE, RECALL, and while V_{CC} is below V_{SWITCH}.
- 34. During power-up and power-down, HSB glitches when HSB pin is pulled up through an external resistor.



Software Controlled STORE/RECALL Cycle

Over the Operating Range

Parameter [35, 36]	Description	25	ns	45	Unit	
Falameter	Description	Min	Max	Min	Мах	Unit
t _{RC}	STORE/RECALL initiation cycle time	25	-	45	-	ns
t _{SA}	Address setup time	0	-	0	-	ns
t _{CW}	Clock pulse width	20	-	30	-	ns
t _{HA}	Address hold time	0	-	0	-	ns
t _{RECALL}	RECALL duration	-	200	-	200	μs
t _{SS} ^[37, 38]	Soft sequence processing time	-	100	-	100	μs

Switching Waveforms



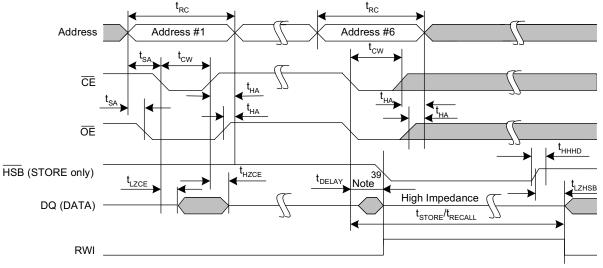
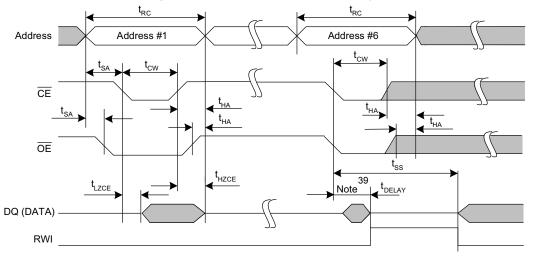


Figure 14. AutoStore Enable/Disable Cycle^[36]



Notes

- Notes 35. The software sequence is clocked with $\overrightarrow{\text{CE}}$ controlled or $\overrightarrow{\text{OE}}$ controlled reads. 36. The six consecutive addresses must be read in the order listed in Table 1. WE must be HIGH during all six consecutive cycles. 37. This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command. 38. Commands such as STORE and RECALL lock out I/O until operation is complete which further increases this time. See the specific command. 39. DQ output data at the sixth read may be invalid since the output is disabled at t_{DELAY} time.

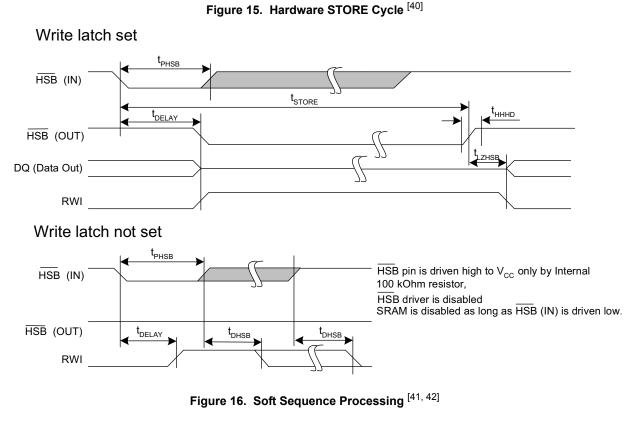


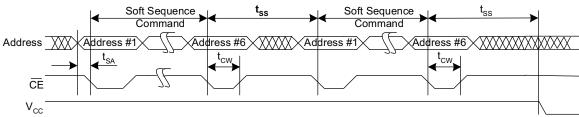
Hardware STORE Cycle

Over the Operating Range

Parameter	Description	Min	Мах	Unit
t _{DHSB}	HSB to output active time when write latch not set	_	25	ns
t _{PHSB}	Hardware STORE pulse width	15	_	ns

Switching Waveforms





Notes

- 40. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place.
- Har Straw when as not taken place size the last nonvolatile cycle, in Autostore of Hardware STORE takes place.
 This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command.
 Commands such as STORE and RECALL lock out I/O until operation is complete which further increases this time. See the specific command.



Truth Table For SRAM Operations

HSB must remain HIGH for SRAM operations.

Table 5. Truth Table

CE	WE	OE	Inputs/Outputs	Mode	Power
Н	Х	Х	High Z	Deselect/Power-down	Standby
L	Н	L	Data out (DQ ₀ –DQ ₇)	Read	Active
L	Н	Н	High Z	Output disabled	Active
L	L	Х	Data in (DQ ₀ –DQ ₇)	Write	Active

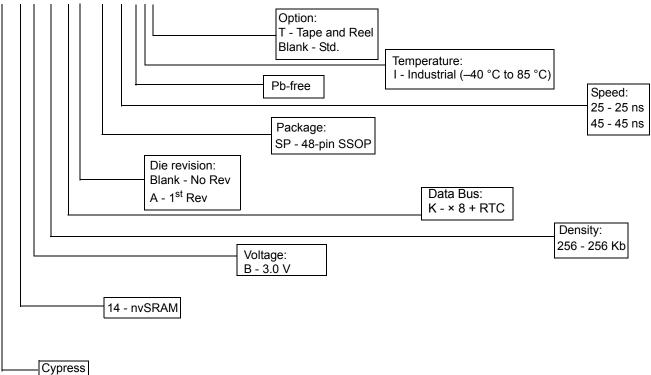
Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
25	CY14B256KA-SP25XIT	51-85061	48-pin SSOP	Industrial
	CY14B256KA-SP25XI			
45	CY14B256KA-SP45XIT			
	CY14B256KA-SP45XI			

All the above parts are Pb-free.

Ordering Code Definitions

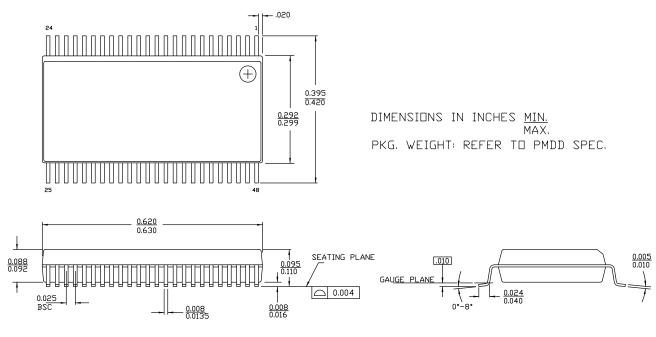
CY 14 B 256 K A - SP 25 X I T





Package Diagram

Figure 17. 48-pin SSOP (300 Mils) Package Outline, 51-85061



51-85061 *F





Acronyms

Acronym	Description
BCD	Binary Coded Decimal
CE	Chip Enable
CMOS	Complementary Metal Oxide Semiconductor
EIA	Electronic Industries Alliance
HSB	Hardware Store Busy
I/O	Input/Output
nvSRAM	non-volatile Static Random Access Memory
OE	Output Enable
PCB	Printed Circuit Board
RoHS	Restriction of Hazardous Substances
RTC	Real Time Clock
RWI	Read and Write Inhibited
SRAM	Static Random Access Memory
SSOP	Shrink Small Outline Package
WE	Write Enable

Document Conventions

Units of Measure

Symbol	Unit of Measure
%	percent
°C	degree celsius
F	farad
Hz	hertz
kHz	kilohertz
kΩ	kilohm
μA	microampere
mA	milliampere
μF	microfarad
MHz	megahertz
μS	microsecond
ms	millisecond
ns	nanosecond
pF	picofarad
ppm	parts per million
V	volt
Ω	ohm
W	watt



Document History Page

Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
**	2763469	GVCH	09/14/09	New data sheet.
*A	2829117	GVCH	12/16/09	Added data retention and endurance table Updated STORE cycles to QuantumTrap from 200K to 1 Million Updated I_{BAK} RTC backup current spec unit from nA to μ A Added Contents. Moved to external web
*В	2922858	GVCH	04/26/10	Pin Definitions: Added more clarity on HSB pin operation Hardware STORE (HSB) Operation: Added more clarity on HSB pin operation Updated HSB pin operation in Figure 12 and updated footnote 34. Updated package diagram.
*C	3143855	GVCH	01/17/2011	Updated Setting the Clock description Added footnote 7 Updated 'W' bit description in Register Map Detail table Updated Maximum Ratings Added t _{RTCp} parameter to RTC Characteristics table Figure 11: Typo error fixed Added Acronyms table and Units of Measure table
*D	3315247	GVCH	07/15/2011	Updated DC Electrical Characteristics (Added Note 12 and referred the sam note in V_{CAP} parameter). Updated Capacitance (Included Input capacitance (for HSB) and Output capacitance (for HSB)). Updated AC Switching Characteristics (Added Note 18 and referred the sam note in Parameters).
*E	3587664	GVCH	04/16/2012	Updated Pin Definitions (Added Note 2 and referred the same note in V _{RTCca} V _{RTCbat} , Xout, Xin, INT pins). Added Note 5 and referred the same note in Figure . Updated Package Diagram.
*F	3660966	GVCH	06/29/2012	Updated DC Electrical Characteristics (Added V_{VCAP} parameter and its detail added Note 13 and referred the same note in V_{VCAP} parameter, also referred Note 14 in V_{VCAP} parameter).
*G	3759143	GVCH	09/28/2012	Updated Real Time Clock Operation (description). Updated Maximum Ratings (Removed "Ambient temperature with power applied" and included "Maximum junction temperature"). Updated Package Diagram (spec 51-85061 (Changed revision from *E to *F
*H	4048849	GVCH	07/03/2013	Updated Pin Definitions: Updated HSB pin description (Added more clarity). Updated Device Operation: Updated AutoStore Operation (Removed sentence "The HSB signal is monitored by the system to detect if an AutoStore cycle is in progress."). Updated Real Time Clock Operation: Updated Backup Power (Added Note). Added RTC External Components. Moved Figure 5 from Flags Register section to RTC External Components section. Added PCB Design Considerations for RTC. Updated in new template.



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Revised November 14, 2014

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